



# STW60NE10

## N - CHANNEL 100V - 0.016Ω - 60A TO-247 STripFET™ POWER MOSFET

| TYPE      | V <sub>DSS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> |
|-----------|------------------|---------------------|----------------|
| STW60NE10 | 100 V            | <0.022 Ω            | 60 A           |

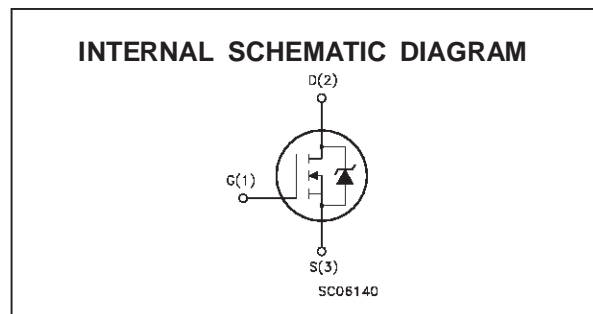
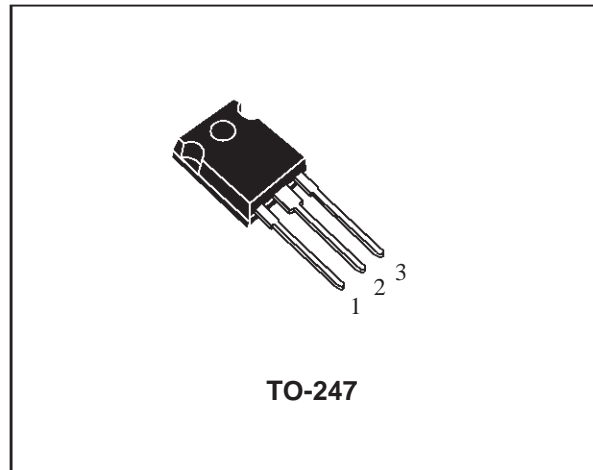
- TYPICAL R<sub>DS(on)</sub> = 0.016 Ω
- EXCEPTIONAL dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- APPLICATION ORIENTED CHARACTERIZATION

### DESCRIPTION

This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

### APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SOLENOID AND RELAY DRIVERS
- MOTOR CONTROL, AUDIO AMPLIFIERS
- DC-DC & DC-AC CONVERTERS
- AUTOMOTIVE ENVIRONMENT (INJECTION, ABS, AIR-BAG, LAMPDRIVERS, Etc.)



### ABSOLUTE MAXIMUM RATINGS

| Symbol              | Parameter   | Value      | Unit |
|---------------------|---|------------|------|
| V <sub>DS</sub>     | Drain-source Voltage (V <sub>GS</sub> = 0)            | 100        | V    |
| V <sub>DGR</sub>    | Drain- gate Voltage (R <sub>GS</sub> = 20 kΩ)         | 100        | V    |
| V <sub>GS</sub>     | Gate-source Voltage                                   | ± 20       | V    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 25 °C  | 60         | A    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 100 °C | 42         | A    |
| I <sub>DM</sub> (•) | Drain Current (pulsed)                                | 240        | A    |
| P <sub>tot</sub>    | Total Dissipation at T <sub>c</sub> = 25 °C           | 180        | W    |
|                     | Derating Factor                                       | 1.2        | W/°C |
| dv/dt (1)           | Peak Diode Recovery voltage slope                     | 9          | V/ns |
| T <sub>stg</sub>    | Storage Temperature                                   | -65 to 175 | °C   |
| T <sub>j</sub>      | Max. Operating Junction Temperature                   | 175        | °C   |

(•) Pulse width limited by safe operating area

(1) I<sub>SD</sub> ≤ 60 A, di/dt ≤ 200 A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>j</sub> ≤ T<sub>JMAX</sub>

## STW60NE10

### THERMAL DATA

|                |  |     |      |               |
|----------------|--|-----|------|---------------|
| $R_{thj-case}$ | Thermal Resistance Junction-case               | Max | 0.83 | $^{\circ}C/W$ |
| $R_{thj-amb}$  | Thermal Resistance Junction-ambient            | Max | 30   | $^{\circ}C/W$ |
| $R_{thc-sink}$ | Thermal Resistance Case-sink                   | Typ | 0.1  | $^{\circ}C/W$ |
| $T_I$          | Maximum Lead Temperature For Soldering Purpose |     | 300  | $^{\circ}C$   |

### AVALANCHE CHARACTERISTICS

| Symbol   | Parameter  | Max Value | Unit |
|----------|--|-----------|------|
| $I_{AR}$ | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by $T_j$ max)               | 60        | A    |
| $E_{AS}$ | Single Pulse Avalanche Energy (starting $T_j = 25^{\circ}C$ , $I_D = I_{AR}$ , $V_{DD} = 35 V$ ) | 500       | mJ   |

### ELECTRICAL CHARACTERISTICS ( $T_{case} = 25^{\circ}C$ unless otherwise specified)

OFF

| Symbol        | Parameter  | Test Conditions   | Min. | Typ. | Max.      | Unit               |
|---------------|--|---|------|------|-----------|--------------------|
| $V_{(BR)DSS}$ | Drain-source Breakdown Voltage                   | $I_D = 250 \mu A$ $V_{GS} = 0$  | 100  |      |           | V                  |
| $I_{DSS}$     | Zero Gate Voltage Drain Current ( $V_{GS} = 0$ ) | $V_{DS} = \text{Max Rating}$<br>$V_{DS} = \text{Max Rating}$ $T_c = 125^{\circ}C$ |      |      | 1<br>10   | $\mu A$<br>$\mu A$ |
| $I_{GSS}$     | Gate-body Leakage Current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 20 V$   |      |      | $\pm 100$ | nA                 |

ON (\*)

| Symbol       | Parameter                         | Test Conditions  | Min. | Typ.  | Max.  | Unit     |
|--------------|-----------------------------------|--|------|-------|-------|----------|
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{DS} = V_{GS}$ $I_D = 250 \mu A$                          | 2    | 3     | 4     | V        |
| $R_{DS(on)}$ | Static Drain-source On Resistance | $V_{GS} = 10 V$ $I_D = 30 A$                                 |      | 0.016 | 0.022 | $\Omega$ |
| $I_{D(on)}$  | On State Drain Current            | $V_{DS} > I_{D(on)} \times R_{DS(on)max}$<br>$V_{GS} = 10 V$ | 60   |       |       | A        |

### DYNAMIC

| Symbol       | Parameter                    | Test Conditions  | Min. | Typ. | Max. | Unit |
|--------------|------------------------------|--|------|------|------|------|
| $g_{fs} (*)$ | Forward Transconductance     | $V_{DS} > I_{D(on)} \times R_{DS(on)max}$ $I_D = 18 A$ |      | 30   |      | S    |
| $C_{iss}$    | Input Capacitance            | $V_{DS} = 25 V$ $f = 1 MHz$ $V_{GS} = 0$               |      | 5300 |      | pF   |
| $C_{oss}$    | Output Capacitance           |  |      | 640  |      | pF   |
| $C_{rss}$    | Reverse Transfer Capacitance |  |      | 215  |      | pF   |

**ELECTRICAL CHARACTERISTICS** (continued)

**SWITCHING ON**

| Symbol      | Parameter          | Test Conditions  | Min. | Typ. | Max. | Unit |
|-------------|--------------------|--|------|------|------|------|
| $t_{d(on)}$ | Turn-on Delay Time | $V_{DD} = 50\text{ V}$ $I_D = 30\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 10\text{ V}$<br>(Resistive Load, see fig. 3) |      | 28   |      | ns   |
| $t_r$       | Rise Time          |  |      | 100  |      | ns   |
| $Q_g$       | Total Gate Charge  | $V_{DD} = 80\text{ V}$ $I_D = 60\text{ A}$ $V_{GS} = 10\text{ V}$  |      | 142  | 185  | nC   |
| $Q_{gs}$    | Gate-Source Charge |  |      | 27   |      | nC   |
| $Q_{gd}$    | Gate-Drain Charge  |  |      | 59   |      | nC   |

**SWITCHING OFF**

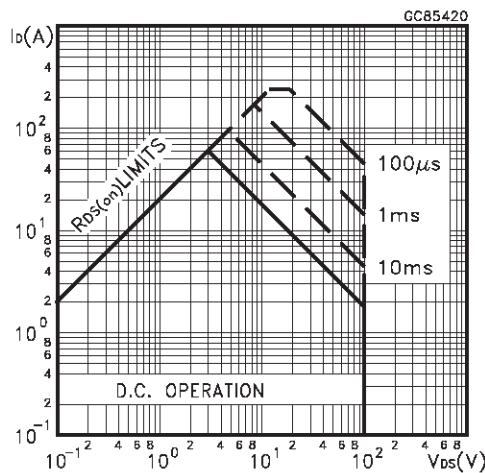
| Symbol        | Parameter             | Test Conditions   | Min. | Typ. | Max. | Unit |
|---------------|-----------------------|---|------|------|------|------|
| $t_{d(off)}$  | Turn-off Delay Time   | $V_{DD} = 50\text{ V}$ $I_D = 30\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 10\text{ V}$<br>(Resistive Load, see fig. 3)    |      | 160  |      | ns   |
| $t_f$         | Fall Time             |   |      | 45   |      | ns   |
| $t_{r(voff)}$ | Off-voltage Rise Time | $V_{clamp} = 80\text{ V}$ $I_D = 60\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 10\text{ V}$<br>(Inductive Load, see fig. 5) |      | 40   |      | ns   |
| $t_f$         | Fall Time             |   |      | 45   |      | ns   |
| $t_c$         | Cross-over Time       |   |      | 85   |      | ns   |

**SOURCE DRAIN DIODE**

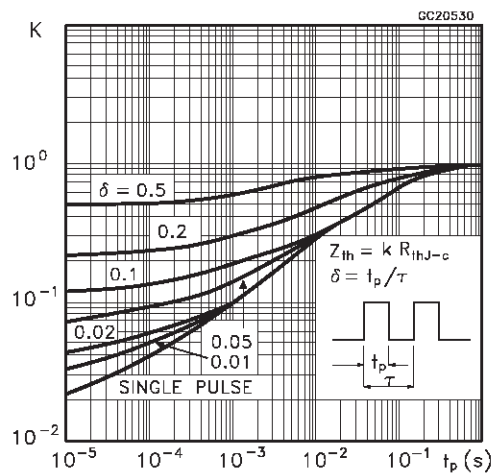
| Symbol             | Parameter                     | Test Conditions   | Min. | Typ. | Max. | Unit          |
|--------------------|-------------------------------|---|------|------|------|---------------|
| $I_{SD}$           | Source-drain Current          |   |      |      | 60   | A             |
| $I_{SDM}(\bullet)$ | Source-drain Current (pulsed) |   |      |      | 240  | A             |
| $V_{SD}(\ast)$     | Forward On Voltage            | $I_{SD} = 60\text{ A}$ $V_{GS} = 0$   |      |      | 1.5  | V             |
| $t_{rr}$           | Reverse Recovery Time         | $I_{SD} = 60\text{ A}$ $di/dt = 100\text{ A}/\mu\text{s}$<br>$V_{DD} = 50\text{ V}$ $T_j = 150\text{ }^\circ\text{C}$<br>(see test circuit, fig. 5) |      | 170  |      | ns            |
| $Q_{rr}$           | Reverse Recovery Charge       |   |      | 1.02 |      | $\mu\text{C}$ |
| $I_{RRM}$          | Reverse Recovery Current      |   |      | 12   |      | A             |

(\*) Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %  
 (•) Pulse width limited by safe operating area

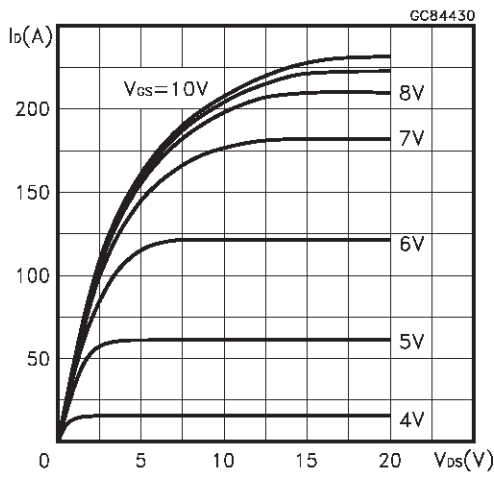
**Safe Operating Area**



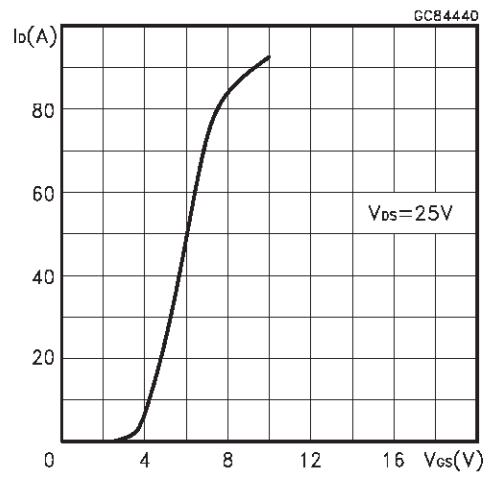
**Thermal Impedance**



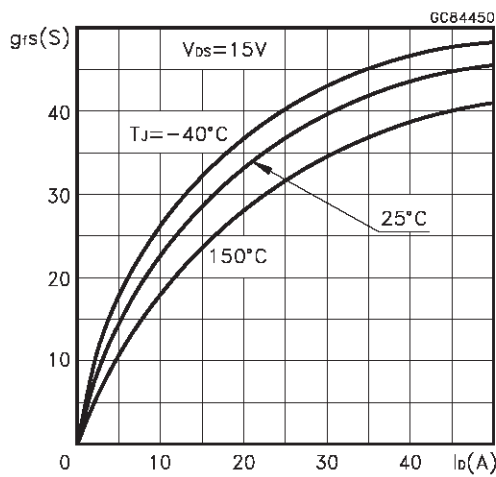
Output Characteristics



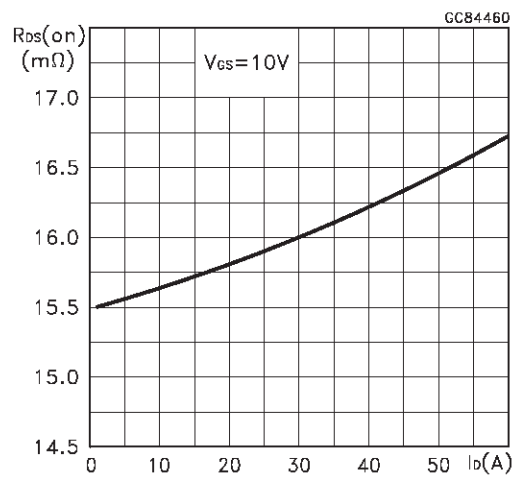
Transfer Characteristics



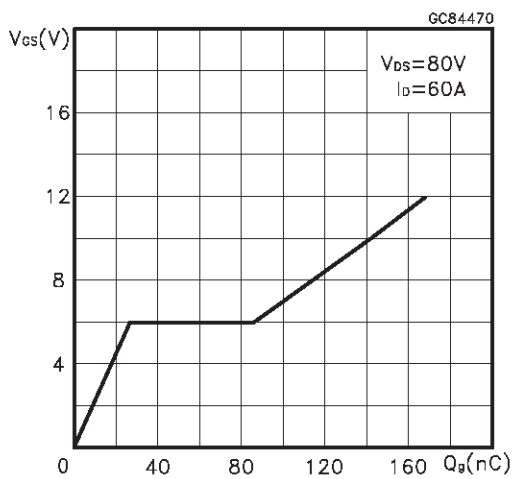
Transconductance



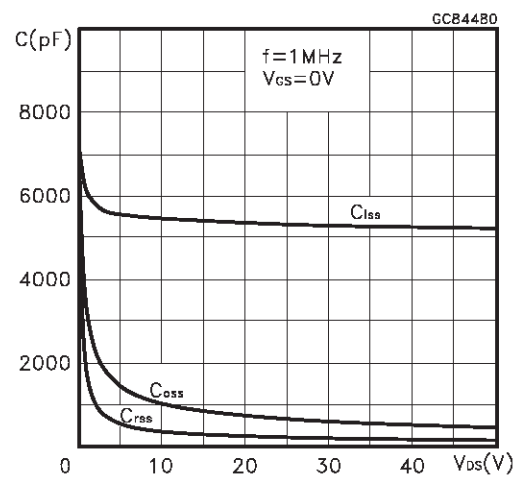
Static Drain-source On Resistance



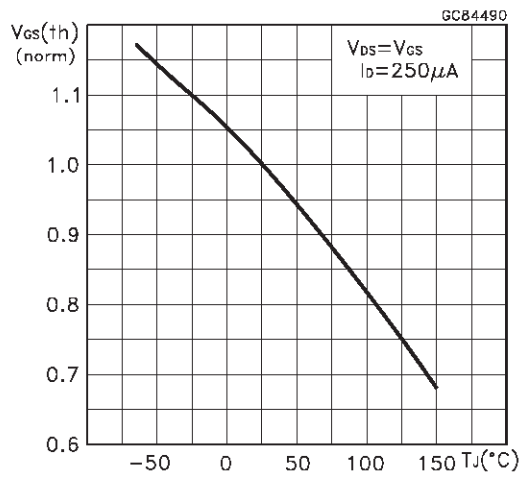
Gate Charge vs Gate-source Voltage



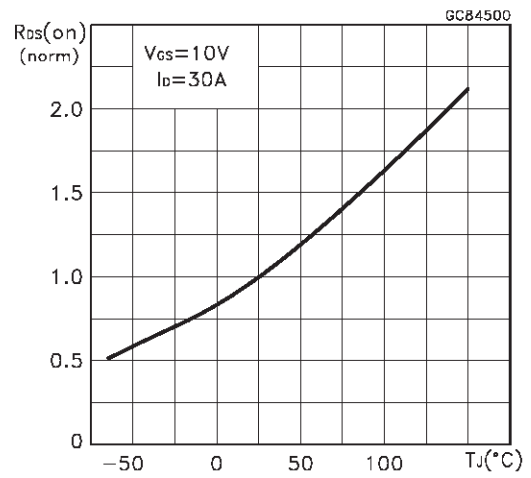
Capacitance Variations



Normalized Gate Threshold Voltage vs Temperature



Normalized On Resistance vs Temperature



Source-drain Diode Forward Characteristics

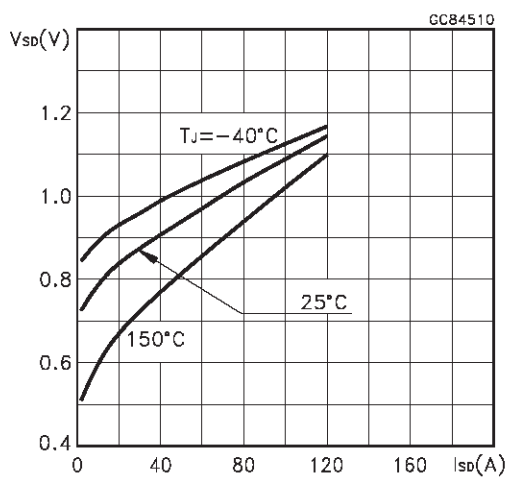


Fig. 1: Unclamped Inductive Load Test Circuit



Fig. 2: Unclamped Inductive Waveform

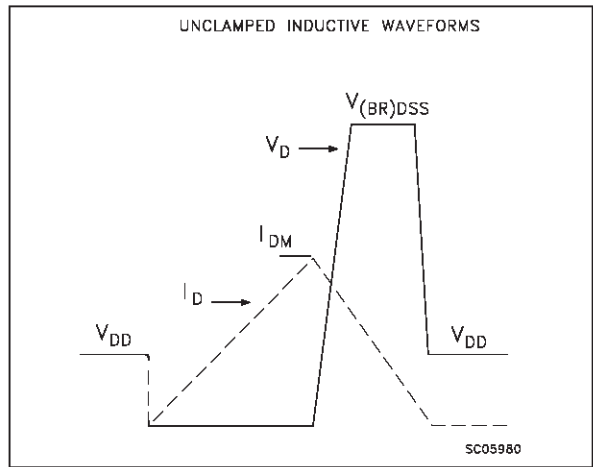


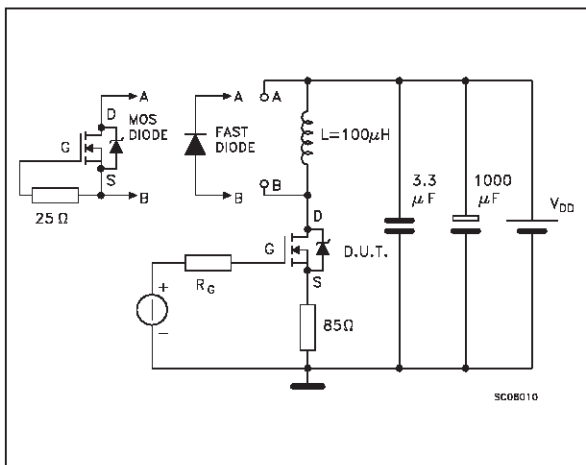
Fig. 3: Switching Times Test Circuits For Resistive Load



Fig. 4: Gate Charge test Circuit

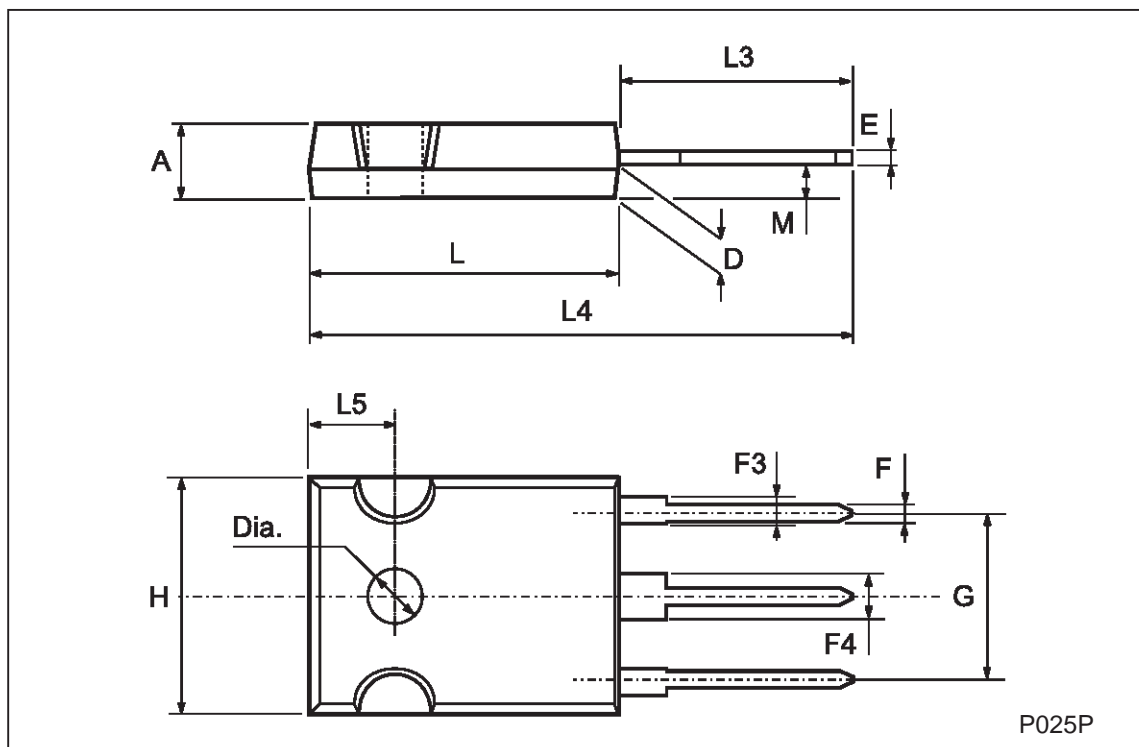


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times



## TO-247 MECHANICAL DATA

| DIM. | mm   |      |      | inch  |       |       |
|------|------|------|------|-------|-------|-------|
|      | MIN. | TYP. | MAX. | MIN.  | TYP.  | MAX.  |
| A    | 4.7  |      | 5.3  | 0.185 |       | 0.209 |
| D    | 2.2  |      | 2.6  | 0.087 |       | 0.102 |
| E    | 0.4  |      | 0.8  | 0.016 |       | 0.031 |
| F    | 1    |      | 1.4  | 0.039 |       | 0.055 |
| F3   | 2    |      | 2.4  | 0.079 |       | 0.094 |
| F4   | 3    |      | 3.4  | 0.118 |       | 0.134 |
| G    |      | 10.9 |      |       | 0.429 |       |
| H    | 15.3 |      | 15.9 | 0.602 |       | 0.626 |
| L    | 19.7 |      | 20.3 | 0.776 |       | 0.779 |
| L3   | 14.2 |      | 14.8 | 0.559 | 0.413 | 0.582 |
| L4   |      | 34.6 |      |       | 1.362 |       |
| L5   |      | 5.5  |      |       | 0.217 |       |
| M    | 2    |      | 3    | 0.079 |       | 0.118 |
| Dia  | 3.55 |      | 3.65 | 0.140 |       | 0.144 |



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